

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/510,233	GEHRKE ET AL.	
Examiner	Art Unit	
Sisay Yacob	2612	

SEARCHED				
Class	Subclass	Date	Examiner	
340	870.07	12/21/2007	S.Y.	
340	870.01+	12/21/2007	S.Y.	
340	\$.CCLS.	12/21/2007	S.Y.	
375	224	12/21/2007	S.Y.	
713	153+	12/21/2007	S.Y.	
710	305	12/21/2007	S.Y.	
702	1, 30	12/21/2007	S.Y.	
702	127, 183	12/21/2007	S.Y.	
324	\$.CCLS.	12/21/2007	S.Y.	
73	112+	12/21/2007	S.Y.	
			,	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Same as	above	12/21/2007	S.Y.	
	I			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Searched EAST:				
US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	12/21/2007	S.Y.		
Searches				
PLUS	12/21/2007	S.Y.		
GOOGLE				
Inventors Names Search:				
Gehrke-Martin.inv.	12/21/2007	S.Y.		
Beuel-Stefan.inv.				
· · · · · ·				
•				